

**Search Notes**

Application/Control No.

10/001,742

Examiner

Djenane M. Bayard

Applicant(s)/Patent under  
Reexamination

BOHRER ET AL.

Art Unit

2141

**SEARCHED**

Class	Subclass	Date	Examiner
709	226	8/3/2005	DB
713	200	8/3/2005	DB
709	213	8/3/2005	DB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
79	226/213	8/3/2005	DB
713	200	8/3/2005	

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	8/3/2005	DB
Consulted with Zarni Maung	7/27/2005	DB
Consulted with search mnetor	8/3/2005	DB
Npl Search IEEE, google	7/27/2005	DB
EIC fast and focus	7/27/2005	DB